

8K X 8 CMOS Electrically Erasable PROM 5ms Nonvolatile Write Cycle

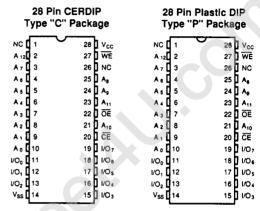
FEATURES

- Fast Read Access Times
 - 120ns, 150ns, 200ns and 250ns
- **■** Low CMOS Power Consumption
 - 60mA (Active)
 - 150µA (Standby)
- 5 Volt-only Operation
 Including write
- Fast Nonvolatile Write Cycle
 - Internally latched data and address
 - 120ns byte-load cycle
 - 5ms (max.) nonvolatile write cycle
- Self-Timed Writes
 - Effective 75µs/byte write
 - 64 byte page input buffer
 - Auto-erase before write
 - DATA Polling
 - Toggle bit
- Software Mode Control
- Automatic Page Write Mode
 - 64 byte page size
 - 5ms page write time
- On-chip Inadvertent Write Protection
- 10,000 Rewrites per Byte
- 10 Year Secure Data Retention
- ESD Protected to 2000V

OVERVIEW

The XL28C64B is a full-featured, 8K x 8 bit CMOS E²PROM (Electrically Erasable Programmable Read Only Memory). Operationally, it is compatible with industry standard 64K devices, but offers improved speed and power efficiency. Read access times can be as low as 120ns; standby current, less than 200µA. It features a page-wide input buffer and improved protection against inadvertent writes. Operating modes function from a single 5V power supply, and the XL28C64B is manufactured with EXEL's proven double-metal, 1.4µ CMOS process.

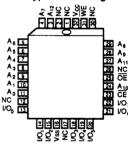
PIN CONFIGURATIONS



28 Pin SOIC Type "J" Package



32 Pin PLCC Type "D" Package



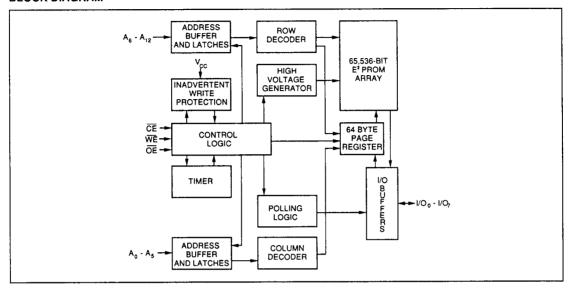
PIN NAMES

A0-A12	Address Inputs
1/00-1/07	Data Inputs/Outputs
CE	Chip Enable
ŌĒ	Output Enable
WE	Write Enable
Vcc	Supply Voltage
Vss	Power and Signal Ground
NC <	No Connect





BLOCK DIAGRAM



The sophisticated architecture of this device provides complete and automatic control of the nonvolatile write cycle eliminating the need for external timers, latches, high voltage generators and supplemental inadvertent write protection circuitry. It fits into standard SRAM sockets and responds to typical SRAM write commands.

The fully-automatic 64-byte page-write allows the entire memory to be programmed in less than 0.65 sec. Internal latches, for address and data, free the system bus during the 5ms self-timed, nonvolatile write period. Moreover, the byte-load cycle time matches the read access time, adding to system performance.

Inadvertent writes are inhibited by a wide range of protections built into the XL28C64B. A low Vcc lockout feature disables nonvolatile write cycles when Vcc drops below 3.5V (Vwi) (typical). Additionally, the XL28C64B features power-on reset and noise protected WE.

The XL28C64B is compatible with existing 64K E²PROMs—both pinout and operating modes conform to industry standards. This compatibility extends to higher and lower density E²PROMs as well.

APPLICATIONS

The nonvolatile storage in the XL28C64B replaces dip switches as a means of storing configuration data. It delivers firmware for booting up systems, and for operating industrial and process controllers, traffic controllers, robotics and telemetry, measuring instruments and appliance controls. It retains phone numbers and messages in telephones and facsimile machines. The XL28C64B is ideal in applications that are self-adapting, such as video games and systems that require automatic re-calibration, as well as those that are subject to power failures.

ENDURANCE and DATA RETENTION

The XL28C64B is designed for applications requiring up to 10,000 data changes per E²PROM byte ensuring a guaranteed endurance of over 81 million data changes per device. It provides 10 years of secure data retention, with or without power applied after the data is written.

DEVICE OPERATION

Three control pins (\overline{CE} , \overline{OE} and \overline{WE}) select all standard user-operating modes for the XL28C64B. Chip erase (typically executed during test procedures) requires a higher supply voltage on the \overline{OE} input pin. This conforms with existing E²PROM standards.

Read Mode

Data is read from the XL28C64B by bringing both $\overline{\text{CE}}$ and $\overline{\text{OE}}$ LOW while keeping $\overline{\text{WE}}$ HIGH. With the read mode selected, address lines can be changed at any time, in any order to read data at various locations in the E²PROM array. Read access time is measured from the latter of either the time when the controlling line goes LOW ($\overline{\text{CE}}$ or $\overline{\text{OE}}$), or the time when the address is established.

The device can be read an unlimited number of times, because the stored charge that defines the bit state is not affected by a read cycle.

Write Mode

The XL28C64B uses a two-step process to store new data. Byte-load cycles fill latches in a volatile page buffer. A subsequent nonvolatile write cycle transfers this data in the page-buffer to the E²PROM array without user intervention.

The XL28C64B contains (128) 64-byte pages. Address lines A₆-A₁₂ identify the page; lines A₀-A₅ identify the byte within the page. All bytes written within one nonvolatile write cycle must be on the same page (A₆-A₁₂ must remain unchanged). Any number of the 64 bytes in the page can be written or re-written, in any order; the last data written to any given byte when the nonvolatile write cycle begins is retained.

Either WE or CE can be used to initiate the byte-load cycle. The address is latched into internal address latches upon the last falling edge of WE or CE. An internal byte-load timer is started on the falling edge of the controlling line. The timer provides a 100µs window for initiating the next byte-load cycle. Byte-loading can continue indefinitely if each new load cycle is started within the timeout period.

When the byte-load timer times out, additional external byte-load cycles are ignored and data is automatically transferred from the page buffer to the E²PROM array through an internally managed nonvolatile write cycle.

Byte flags, set during the byte-load cycles, ensure that high voltage is applied only to newly written bytes. By avoiding the unnecessary cycling of bytes, the endurance of the array is extended. The high voltage cycle is immune to any overlapping control pin activity.

An internal write-flag is set on the first byte-load of each write cycle. Data pins remain in a high impedance state except during a byte-load (when they contain the forced input data) or during a $\overline{\text{DATA}}$ polling read (see below). When the high voltage cycle is completed, the write-flag is reset and the operating mode is again determined by the control pins ($\overline{\text{CE}}$, $\overline{\text{OE}}$ and $\overline{\text{WE}}$).

Standby Mode

Whenever \overline{CE} is brought HIGH, the device operates in standby mode, with the I/O pins in a high impedance state. Standby power dissipation is less than 200µA with CMOS level inputs.

Chip Erase — High Voltage Mode

The chip erase mode allows the user to erase the entire E^2PROM array with a single command. The method requires the application of high voltage (V_H) on the \overline{OE} pin, with \overline{CE} at a logical "0." Chip erase is initiated by a standard byte write command, but in this case, the data on the I/O pins is ignored. A byte containing all "1's" is automatically written to all locations in the E^2PROM array. (Refer to the Mode Selection chart.)

DEVICE OPERATION—SOFTWARE CONTROL

Under software control, the XL28C64B offers 5V-only data protection and chip erase. Software control is accomplished by byte-load sequences involving specific address and data patterns.

Short command sequences require three byte-loads; long sequences require six byte-loads. Whenever one of these sequences is recognized in a write operation, it is executed as a software command sequence, and any preceding byte-loads are lost.

MODE SELECTION

CE	ŌĒ	WE	Mode	I/O	Power
VIL	VIL	ViH	Read	Dout	Active
VIL	ViH		Byte Write (WE Controlled)	DIN	Active
	ViH	VIL	Byte Write (CE Controlled)	DiN	Active
VIL	Vн	V _{1L}	Chip Erase*	Data In = X	Active
ViH	Х	X	Standby	HIGH Z	Standby
VIL	VIL	ViH	DATA Polling	D7	Active
Х	VIL	X	Write Inhibit	X	Active

^{*}Contact EXEL for details.



These address and data patterns could conceivably occur in a normal application. However, the protocol utilizes differing page addresses within one write cycle — a practice that is illegal in standard write operations.

Chip Erase Cycle

This software command sequence activates the standard chip erase, but without the high voltage input on the OE pin. Contact EXEL technical support for details.

Set Data Protection Mode (See Figure 1)

This software command sequence disables the high voltage cycle for standard writes (those controlled by the enable lines). Each set-data-protect command can be followed by data for one page of the E²PROM array. Thereafter, standard writes are disabled, and can be enabled only by a disable-data-protect command. However, additional pages can be written by the set-data-protect command.

Set Data Protect Software Command Sequence:

Byte-load	$A_{12} - A_{0}$	1/0,-1/0		
1	1555 (hex)	AA (hex)		
2	0AAA (hex)	55 (hex)		
3	1555 (hex)	A0 (hex)		

When this command is recognized, the part remains in write mode. Any number of normal byte-load cycles can be performed in the same write cycle. When the byte-load timer expires, a normal high voltage cycle occurs, writing the page buffer data to the E²PROM array and setting a nonvolatile data protect bit. If the data protect bit was already set—by a previous set-data-protect command—it remains set. If a power failure interrupts the operation, neither the data nor the protect bit is written.

Setting the data protect bit inhibits only the high voltage cycles of standard writes (those controlled by the enable lines); byte-load cycles are still accepted. When the byte-load timer expires, the part skips the high voltage cycle and becomes accessible to the standard read mode.

Because the data-protect-status bit is a nonvolatile E^2 element, protect mode status is maintained during power off.

Disable Data Protection Mode

This software command sequence re-enables the high voltage cycle of the standard write (see Figure 2). Each disable-data-protect command can be accompanied by data for one page of the E²PROM. Standard writes are then enabled, until disabled by a subsequent set-data-protect command.

Disable Data Protect Software Command Sequence:

Byte-load	A ₁₂ -A ₀	1/0,-1/0
1	1555 (hex)	AA (hex)
2	0AAA (hex)	55 (hex)
3	1555 (hex)	80 (hex)
4	1555 (hex)	AA (hex)
5	0AAA (hex)	55 (hex)
6	1555 (hex)	20 (hex)

The six byte-loads specifying this command leave the part in write mode; any number of normal byte-load cycles can be performed in the same write cycle. When the byte-load timer expires, a normal high voltage cycle occurs, writing the page buffer data to the E²PROM array and setting the nonvolatile data protection. If the data protection was already disabled (by a previous disabledata-protect command), it remains disabled. If a power failure interrupts the operation, neither the data nor the data protection is written. Because the data protect status bit is a nonvolatile E² element, data protection mode status is maintained during power off.

MONITORING DEVICE STATUS

Because the byte-load timer and its high voltage cycle are completely under the control of the XL28C64B, a status register allows the host system to monitor device status.

Status Register

Any read performed during the nonvolatile write cycle is interpreted as a status register read. (Reading the status register has no effect on the byte-load timer, byte-load flags, high voltage cycle or the contents of the page buffer.)

The status of a write operation is monitored in one of two ways; Toggle Polling or $\overline{\text{DATA}}$ Polling. While the non-volatile write cycle is in progress, O_6 will toggle between 0 and 1 on successive reads; O_7 will hold the complement of bit 7 of the last byte loaded. When the write-latch is reset, the write operation is complete. O_6 and O_7 become bits 6 and 7 of the actual byte location. Bit 6 will no longer toggle; bit 7 will no longer be a complement.

While the write cycle is in progress, there is additional information available from the status register, as follows:

Bits 0 and 1: Reserved for use by factory

Bit 2: Always 0

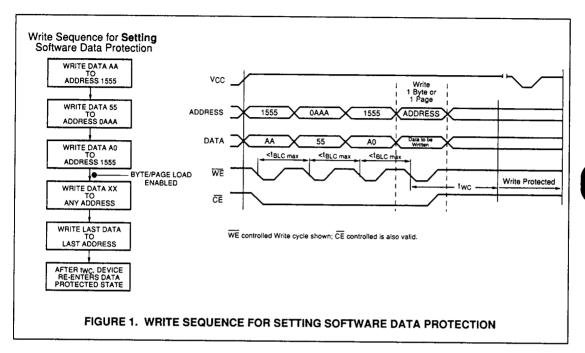
Bit 3: 1 means data protect feature is enabled 0 means data protect feature is disabled

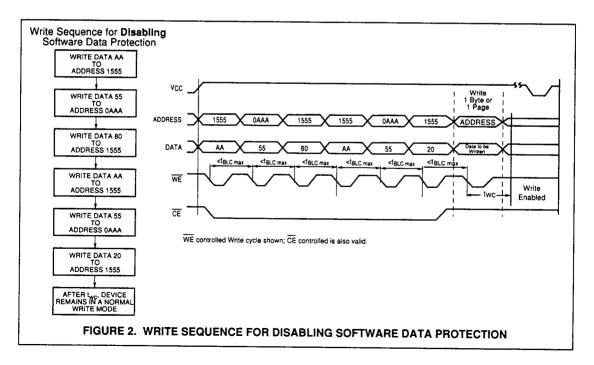
Bit 4: Always 1

Bit 5: Reserved for use by factory
Bit 6: Used in Toggle polling

Bit 7: Used in DATA Polling





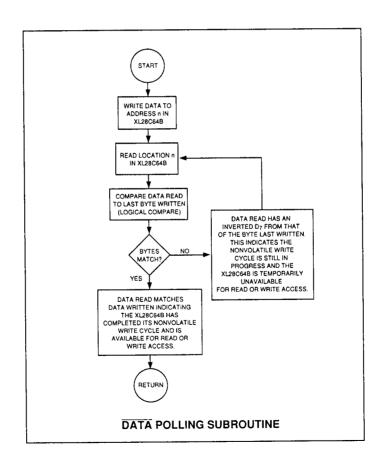




DATA Polling

The XL28C64B provides a feature named DATA polling which enables the host system to determine the status of the device through the use of the system busses. No additional hardware is required. Any attempt to read the part while the XL28C64B is busy executing its nonvolatile write cycle will be interpreted as a DATA polling read. This is performed by exercising the control pins in the same sequence as for a normal read. DATA polling cycles have no effect on the byte-load timer, contents of the data buffer or the nonvolatile cycle timing.

DATA polling is a simple software technique used to determine the status of the XL28C64B. It is executed as a normal read cycle where the target byte location is the same as that of the byte last written to the XL28C64B. During the 5ms (max.) period that the device requires to complete its nonvolatile write cycle, the I/O buffers output the contents of the status register, during a read cycle. I/O₇ is set to output the complement of the value of the MSB of the last byte written to the XL28C64B when a read command is asserted.





The procedure is quite simple. The system simply reads the location last written to in the XL28C64B and executes a compare operation between the data thus retrieved and the original data byte written. If the compare fails, the XL28C64B is still busy with its nonvolatile write cycle. If the compare passes, the nonvolatile write cycle is complete and the device is available for read or write accesses.

This procedure is commonly used to determine the actual nonvolatile write cycle completion timing, eliminating the need to await the 5ms (max.) period specified, and enabling accelerated device loading operations.

WRITE PROTECT MECHANISMS

The XL28C64B features several integrated mechanisms to protect it from inadvertent writes that might occur during system power supply transitions or periods of system noise.

OE Write Inhibit

If \overline{OE} is brought LOW before the \overline{CE} and \overline{WE} write command sequence, the internal nonvolatile write cycle will not occur. See the Mode Selection Table on page 3. In addition to the user-controlled protection mechanisms, the following specialized circuits are built in.

Vcc Lockout

The XL28C64B has a specialized power supply monitor circuit integrated to protect the device from inadvertent write commands asserted by the system during low V_{CC} conditions. This circuitry constantly evaluates the power supply voltage level applied to the XL28C64B and actively inhibits the initiation of nonvolatile write cycles if the applied supply voltage falls below V_{WI}. This circuitry does not abort nor affect nonvolatile write cycles already in progress, yet inhibits new cycles from being initiated.

Power-Up Write Enable Delay

At power on, operation is inhibited until V_{CC} is stable and sufficiently high. Write operations are inhibited until 1ms after V_{CC} reaches 3.0V to allow the system to stabilize while blocking potential inadvertent write commands.

Noise Protection

Write pulses of less than 10ns duration on the \overline{WE} pin will not initiate nonvolatile write cycles.

Data Protection Mode (Software Controlled)

The XL28C64B can be placed in a write-disabled mode through software control.





ABSOLUTE MAXIMUM RATINGS

Temperature Under Bias	-55°C to .125°C
Storage Temperature	CEOC 4- 45000
Lead Soldering Temperature (less than 10 seconds)	2000
Supply Voltage	0 to 6 5V
Supply Voltage Voltage on Any Pin* Voltage on OE Pin*	-1.0 to +7.0V
Voltage on OE Pin*	-1.0 to +15.0V
LOD hating	20001/
DC Culbul Chrient	5mA
*With respect to ground	

NOTE: These are STRESS ratings only. Appropriate conditions for operating these devices are given elsewhere in this specification. Stresses beyond those listed here may permanently damage the part. Prolonged exposure to maximum ratings may affect device reliability. Although this product includes specific circuitry to protect it from electrostatic discharge, conventional precautions should be taken to avoid any voltages higher than the rated maxima.

DC ELECTRICAL CHARACTERISTICS

TA = 0°C to +70°C for the XLS28C64B or -40°C to +85°C for the XLE28C64B, $VCC = 5V \pm 10\%$

Symbol	Parameter	Test Conditions	Min.	Max.	Units
lcc	Vcc Current — Active (TTL)	CE = OE = VIL WE = VIH I/O's = open Ao-A12 toggling at 5MHz		60	mA
Isa	Vcc Current — Standby (TTL)	CE = WE = VIH OE = VIL I/O's = open Ao-A12 = Vcc		2	mA
ISBC	Vcc Current — Standby (CMOS)	CE = WE V cc2V OE = V ss+0.2V I/O's = open Ao-A12 = Vcc		150	μA
<u>lti</u>	Input Leakage Current	Vin = GND to Vcc		10	μA
lro	Output Leakage — Standby	Vout = GND to Vcc CE = VIH		10	μA
VIL	Input Low Voltage		-0.5	0.8	V
VIH	Input High Voltage		2.0	Vcc + 0.5	V
Vol	Output Low Voltage	IOL = 2.1mA		0.4	V
Vон	Output High Voltage	Іон = -400μ A Іон = -10μ A	2.4 Vcc-0.1		٧
VH	High Voltage for Chip Erase		11.4	12.6	V

CAPACITANCE

 $T_A = 25$ °C, f = 1.0MHz

Symbol	Test	Test Conditions	Max.	Units
Cı⁄o	Input/Output Capacitance	Vvo = 0V	10	pF
Cin	Input Capacitance	VIN = 0V	6	pF



AC OPERATING CHARACTERISTICS

READ CYCLE (See Figures 3 and 4)

TA=0°C to +70°C for the XLS28C64B or -40°C to +85°C for the XLE28C64B, VCC=5V+10%

		XL28C	54B-120	XL28C6	4B-150	XL28C	64B-200	XL28C	64B-250	İ
Symbol	Test	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Units
tRC	Read Cycle Time	120		150		200		250		ns
taa	Address Access Time		120		150		200		250	ns
tCE	Chip Enable Access Time		120		150		200		250	ns
toE	Output Enable Access Time		50		60		75		100	ns
tLZ	Chip Enable to Output in Low Z	0		0		0	i	0		ns
tHZ	Chip Disable to Output in High Z	0	50	0	50	0	50	0	50	ns
toLz	Output Enable to Output in Low Z	0		0		0		0		ns
tonz	Output Disable to Output in High Z	0	50	0	50	0	50	0	50	ns
tон	Output Hold from Address Change	15		15		15		15		ns



WRITE CYCLE (See Figures 5, 6 and 7)

TA=0°C to +70°C for the XLS28C64B or -40°C to +85°C for the XLE28C64B, VCC=5V±10%

Symbol	Test	Min.	Max.	Units
twc	Write Cycle Time		5	ms
tBLC	Byte Load Cycle	.120	100	μs
tas	Address Setup Time	0		ns
tah	Address Hold Time	35		ns
tcs	Write Setup Time	0		ns
tсн	Write Hold Time	0		ns
tcw	Chip Enable Pulse Width	50		ns
toes	Output Enable Setup Time	5		ns
toeh	Output Enable Hold Time	5		ns
twp	Write Enable Pulse Width	70		ns
twph	Write Pulse Width High	50		ns
tos	Data Setup Time	30		ns
tDH	Data Hold Time	0	. ,	ns
tov	Data Valid Time		1	μs
tinit	Power-up Initialization Period		20	ms



